

Search Notes

Application/Control No.

10/760,292

Examiner

Ha T. Nguyen

Applicant(s)/Patent under
Reexamination

OHASHI ET AL.

Art Unit

2812

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (see printout)	9/9/2005	HN